Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/783,514	GIST ET AL.	
Examiner	Art Unit	
David Sample	1755	

SEARCHED						
SEARCHED						
Class	Subclass	Date	Examiner			
501	108	6/15/2005	QUI			
	109	6/15/2005	QQ)			
	123	6/15/2005	(LAN)			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East Searched	6/15/2005	ALI		
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